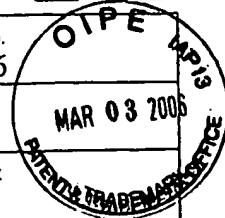


Substitute Form PTO-1449 (Modified)  <b>Information Disclosure Statement by Applicant</b> (Use several sheets if necessary)  (37 CFR §1.98(b))	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 12732-171001	Application No. 10/694,986
	Applicant Masaharu Nagai et al.		
	Filing Date October 29, 2003	Group Art Unit 1756	



U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
DCD	AA	2001/0052950	12-20-2001	Yamazaki et al.			03/16/2001
DCD	AB	2002/0000551	01-03-2002	Yamazaki et al.			03/02/2001
DCD	AC	2002/0127887	09-12-2002	Uehara et al.			05/11/2001
DCD	AD	6,746,965	06-08-2004	Uehara et al.			07/30/2002
DCD	AE	6,432,620	08-13-2002	Arao			08/16/2000
DCD	AF	6,423,477	07-23-2002	Engelen et al.			10/07/1998
DCD	AG	6,207,247	03-27-2001	Morita			03/26/1999
DCD	AH	6,057,081	05-02-2000	Yunogami et al.			09/22/1997
DCD	AI	5,506,168	04-09-1996	Morita et al.			10/11/1994
DCD	AJ	4,692,205	09-08-1987	Sachdev et al.			01/31/1986
DCD	AK	6,497,992	12/24/2002	Yunogami et al.			04/17/2000

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AL							
	AM							
	AN							
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
DCD	AQ	Hatano et al., "A Novel Self-aligned Gate-overlapped LDD Poly-Si TFT with High Reliability and Performance", IEDM 97; Technical Digest of International Electron Devices Meeting, December 7, 1997, pp. 523-526.
DCD	AR	Final Office Action dated December 06, 2005 for U.S. Serial No. 10/405,908 (Your Ref.: 12732-150001, Our Ref.: US6362)
	AS	
	AT	

Examiner Signature  /Daborah Chacko-Davis/	Date Considered  (05/09/2006)
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	